

Search Notes

Application/Control No.

10/540,012

Examiner

BINH Q. TRAN

Applicant(s)/Patent under
Reexamination

MIYAKE ET AL.

Art Unit

3748

SEARCHED

Class	Subclass	Date	Examiner
60	274	02/26/06	BSJ
	278		
	285		
	297		
	276		
123	406.45	2/26/06	BSJ
	406.48		
	430		
123	568.11		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST TEXT SEARCHED	2/26/06	BSJ
INVENTORS SEARCHED	2/26/06	BSJ